

Search Notes



Application No.

10/658,163

Examiner

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Applicant(s)

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Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	1-5 8-13 22-28		
	1-405		
	305-306		
	305, 129		
709	250		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
PLUS searched	1-15-05	27
PALM searched for double patenting	1-13-08	57
EAST (USPAT, epo, jpo, derwent, IBM TDB)	1-18-05	56